# WS3212D

# Over-Voltage Protection IC with 200X constant current source for Li+ charging

## Descriptions

The WS3212D is a fully integrated Over Voltage Protection IC with 200x constant current source for Li-ion charging applications. Over current protection and over temperature protection functions are integrated to prevent chip damage. The charging current is controlled by the GDRV pin. When sinking current from the GDRV pin, the BAT pin delivers the charging current with 200X current gain of GDRV's current.

The WS3212D is available in DFN3x3-10L package. Standard products are Pb-Free and halogen-Free.

: 5.86V

#### Features

- Absolute Maximum Input Voltage : 30V
- Input OVP Threshold
- Constant Current Gain : 200
- Over-Current Protection Threshold : 2A
- Over-Temperature Threshold : 160°C
- VIN to BAT On-Resistance : 160mΩ
- Charging Status Indicator

# Applications

Cell Phones

Http//:www.willsemi.com



#### Pin configuration (Top view)



# **Order information**

Device	Package	Shipping
WS3212D-10/TR	DFN3x3-10L	3000/Reel&Tape



# **Typical Applications**



# **Block Diagram**





# **Pin Descriptions**

Pin No.	Symbol	Function
1	OUT	Power supply output pin. This pin provides supply voltage to the PMIC input. Bypass to GND with a 1uF (min.) ceramic capacitor.
2, 3	VIN	Power supply input pin. This pin is connected to external DC supply and bypassed to GND with a 1uF (min.) ceramic capacitor.
4	/ACOK	Open-drain charging status output pin. When charging battery, the ACOK pin is pulled low by an internal N-channel MOSFET.
5, 6	GND	Ground pin.
7, 8	BAT	Charging current output pin. This pin provides supply source current to battery.
9	GDRV	Charging current control pin. When sinking current from this pin, the BAT pin will source out a current whose magnitude is 200 X $I_{GDRV}$ .
10	CHG_LDO	Charge_LDO output voltage with 1.5KΩ resistor.



## **Absolute Maximum Ratings**

Parameter	Symbol	Rating	Unit	
VIN Input Voltage (VIN to GND Voltage)	V <sub>IN</sub>	-0.3~30	V	
BAT Voltage	V <sub>BAT</sub>	-0.3~7	V	
BAT Charging Current	I <sub>BAT</sub>	1.5	А	
CHG_LDO to GND Voltage	$V_{CHG_LDO}$	7	V	
GDRV to GND Voltage	$V_{GDRV}$	7	V	
OUT to GND Voltage	V <sub>OUT</sub>	9	V	
Junction Temperature	TJ	160	°C	
Operation Temperature	T <sub>OPR</sub>	-45~85	°C	
Storage Temperature	T <sub>STG</sub>	-65~125	°C	
Lead Temperature (Soldering 10s)		260	°C	
	HBM	5	kV	
ESD Ratings	MM	200	V	
	CDM	2	kV	
Latch-Up		800	mA	

**Note:** These are stress ratings only. Stresses exceeding the range specified under "Absolute Maximum Ratings" may cause substantial damage to the device. Functional operation of this device at other conditions beyond those listed in the specification is not implied and prolonged exposure to extreme conditions may affect device reliability.

## Recommend Operating Conditions (T<sub>A</sub>=25°C, unless otherwise noted)

Parameter	Symbol	Rating	Unit
Supply Voltage	V <sub>IN</sub>	4.5~5.5	V
Charge Current	I <sub>CC</sub>	0.1~1.2	А
Ambient Temperature	T <sub>A</sub>	-40~85	°C
Junction Temperature	ΤJ	-40~125	°C



# Electronics Characteristics (V<sub>IN</sub>=5V, T<sub>A</sub>=25°C, V<sub>BAT</sub>=4V, C<sub>OUT</sub>=1uF, unless otherwise noted)

Symbol	Parameter	Condition	Min.	Тур.	Max.	Unit		
DC Characteristics								
R <sub>ON1</sub>	VIN to OUT On Resistance	I <sub>OUT</sub> =1A		75	150	mΩ		
R <sub>ON2</sub>	Charge (OUT to BAT) On Resistance			85				
R <sub>LDO</sub>	CHG_LDO Output Series Resistance		1.2	1.5	1.8	kΩ		
I <sub>VIN</sub>	VIN Supply Current	I <sub>OUT</sub> =0A, CHG_LDO and GDRV pins open	100	188	300	uA		
I <sub>VIN(OVP)</sub>	VIN Supply Current under OVP	V <sub>IN</sub> =6.5V	50	104	200			
I <sub>CHG(min)</sub>	Minimum Charge Current (BAT pin)			25		mA		
l <sub>oc</sub>	Over-Current Limit Level		2			А		
N <sub>CUR</sub>	Current Mirror Gain	I <sub>BAT</sub> =1A	180	200	220	A/A		
M	$V_{\text{OUT}}\text{-}V_{\text{BAT}}$ Lockout Release Threshold	V <sub>OUT</sub> rising		100		mV		
V ASD	V <sub>OUT</sub> -V <sub>BAT</sub> Lockout Threshold	V <sub>OUT</sub> falling	5	60		mV		
V	VIN UVP Threshold	V <sub>IN</sub> falling	2.803	2.92	3.037	V		
V UVP	VIN UVP Hysteresis	V <sub>IN</sub> rising		3.08		V		
M	VIN OVP Threshold	V <sub>IN</sub> rising	5.626	5.86	6.094	V		
VOVP	VIN OVP Hysteresis	V <sub>IN</sub> falling		5.74		V		
Thermal Protection and Timers								
т	Thermal Shutdown Threshold	T <sub>A</sub> rising		160		°C		
I OTP	Thermal Shutdown Hysteresis	T <sub>A</sub> falling		25				
T <sub>OVP</sub>	VIN OVP Propagation Delay	V <sub>IN</sub> rise from 5V to 6V		80		ns		
T <sub>ON(OVP)</sub>	VIN OVP Recovery Time			10				
T <sub>ON</sub>	V <sub>OUT</sub> Power-On Time	V <sub>OUT</sub> =90%V <sub>IN</sub>	5	10	15	ms		
T <sub>START</sub>	ACOK Start-Up Time		10	20	30			



## **Operation Information** VIN Under-Voltage Protection (UVP)

The WS3212D integrates an under-voltage protection circuit to shut off the output when input voltage falls below the UVP threshold. The UVP circuit has hysteresis and a de-glitch feature so that it will typically ignore undershoot transients on the input.

#### VIN Over-Voltage Protection (OVP)

If the input voltage rises above  $V_{OVP}$ , the internal switch MOSFET will turn off immediately to protect the system connected to OUT pin. When the input voltage falls below the input OVP hysteresis, the MOSFET is turned on again after 10ms recovery time. The OVP recovery time  $T_{ON(OVP)}$  is designed to provide noise immunity against transient conditions.

#### **Power-On Operation**

When input voltage satisfies both UVP and OVP restrictions for 10ms blanking time, the output voltage starts a soft-start to reduce the inrush current. For battery charging circuit to start work, VIN should remain in this valid status for another 10ms time.

# Internal N-Channel Power MOS and Bootstrap Gate Control

The WS3212D integrates an N-channel MOSFET with bootstrap gate control to replace the external NPN transistor for cell phone's PMIC. When valid input voltage is established, the bootstrap gate control circuitry will pull up the N-channel MOSFET's gate voltage gradually to turn on its N-channel. The N-channel MOSFET achieves lower on resistance within limited area, comparing to its P-channel counterpart.

#### **Current Limit**

The output current is monitored by the internal current limit circuit. When the output current exceeds the current limit threshold, the device clamps the output current by modifying the gate voltage of N-channel power MOS.

#### **Charging Status Indicator (/ACOK)**

ACOK pin is an open-drain charging status indicator with two states: pull-down, and high impedance. The pull-down state indicates that the WS3212D is in charging status, while the high impedance indicates the opposite. Charging circuitry is powered by OUT pin. Charging soft-start timer of 10ms is added to make sure OUT is ready. /ACOK can also be used to detect charging states by a microprocessor using a pull-up resistor.

#### Charging Current Control

The charging current is controlled by the GDRV pin. When sourcing current from the GDRV pin, the BAT pin delivers the charging current whose magnitude is 200-fold of GDRV's current. The  $I_{BAT}$  current can be calculated by the following equation:

 $I_{BAT}=200XI_{GDRV}$ 

where

 $I_{BAT}$  is the current flowing out from the BAT pin.  $I_{GDRV}$  is the current flowing out from the GDRV pin.

#### **Temperature Protection**

When the junction temperature exceeds 160°C, the internal thermal sense circuit turns off the power MOS to cool down the chip. When the device's junction temperature cools by 25°C, the internal thermal sense circuit will enable the device, resulting in a pulsed output during continuous thermal protection. Thermal protection is designed to protect the IC in the event of over temperature conditions. For normal operation, the junction temperature cannot exceed 125°C.

# Typical Characteristics (T<sub>A</sub>=25°C, unless otherwise noted)





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# **Operating Waveforms**

Refer to the typical application circuit. The test condition is  $V_{IN}=5V$ ,  $T_A=25$  °C unless otherwise specified.



#### Normal Power-On and Power-Off

Power-On Power-Off

/ر (1) 3.80 V

100M次/秒 10M点

5.00 V
1.00 A Ω

10.0ms

4 ÎIN

**1** 5.00 \ **3** 5.00 \ 250M次/秒 10M 点 1 \ 3.80 V 1 11月2017 15:09:38

4 IIN

> **1** 5.00 **3** 5.00

4 1.00 A

1 11月2017 15:10:33



## **Operating Waveforms**

Refer to the typical application circuit. The test condition is V<sub>IN</sub>=5V, T<sub>A</sub>=25 °C unless otherwise specified.



# Input OVP and Recovery

( $V_{IN}$  rises from 5V to 6V, then drops to 5V)



## **Operating Waveforms**

Refer to the typical application circuit but remove capacitors on VIN pin and OUT pin. The test condition is  $V_{IN}$ =5V,  $T_A$ =25 °C unless otherwise specified.



Input OVP Propagation Delay (V<sub>IN</sub> rises from 5V to 6.5V)



# **Package Outline Dimensions**





Symbol	Dimensions in Millimeters				
Symbol	Min.	Тур.	Max.		
A	0.700	0.750	0.800		
A1	0.000	0.020	0.050		
A2	0.203 Ref.				
D	2.900	3.000	3.100		
E	2.900 3.000		3.100		
D1	2.300 2.400 2.500				
E1	1.600 1.700 1.8		1.800		
b	0.200 0.250 0.300		0.300		
е	0.500 Тур.				
L	0.324 0.400 0.476				

A



# TAPE AND REEL INFORMATION

# **Reel Dimensions**





# **Quadrant Assignments For PIN1 Orientation In Tape**





User Direction of Feed

RD	Reel Dimension	🔲 7inch	🔽 13inch		
W	Overall width of the carrier tape	🗖 8mm	🔽 12mm	🗌 16mm	
P1	Pitch between successive cavity centers	🗖 2mm	🗌 4mm	🗹 8mm	
Pin1	Pin1 Quadrant	<b>☑</b> Q1	🗖 Q2	🗖 Q3	🗖 Q4